# **ON Semiconductor**

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# **Power MOSFET**

# 100 V, 12 A, N-Channel, Logic Level DPAK

#### **Features**

- Source—to—Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Avalanche Energy Specified
- Logic Level
- Pb-Free Packages are Available

#### **Typical Applications**

- PWM Motor Controls
- Power Supplies
- Converters

#### **MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	100	Vdc
Drain-to-Source Voltage ( $R_{GS} = 1.0 \text{ M}\Omega$ )	$V_{DGR}$	100	Vdc
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	± 20	Vdc
Drain Current – Continuous @ T <sub>A</sub> = 25°C – Continuous @ T <sub>A</sub> =100°C – Pulsed (Note 3)	I <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	12 9.0 44	Adc Apk
Total Power Dissipation Derate above 25°C Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 1) Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 2)	P <sub>D</sub>	56.6 0.38 1.76 1.28	W W/°C W W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ( $V_{DD} = 50$ Vdc, $V_{GS} = 5.0$ Vdc, $I_L = 12$ Apk, $L = 1.0$ mH, $R_G = 25$ $\Omega$ )	E <sub>AS</sub>	72	mJ
Thermal Resistance  - Junction-to-Case  - Junction-to-Ambient (Note 1)  - Junction-to-Ambient (Note 2)	$R_{ heta JC} \ R_{ heta JA} \ R_{ heta JA}$	2.65 85 117	°C/W
Maximum Temperature for Soldering Purposes, (1/8" from case for 10 s)	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. When surface mounted to an FR4 board using 0.5 sq in pad size.
- When surface mounted to an FR4 board using the minimum recommended pad size.
- 3. Pulse Test: Pulse Width = 10  $\mu$ s, Duty Cycle = 2%.

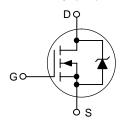


#### ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX	
100 V	118 mΩ @ 5.0 V	12 A	

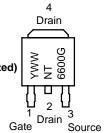
#### N-Channel



#### MARKING DIAGRAMS

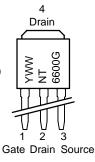


DPAK CASE 369C (Surface Mounted) STYLE 2





DPAK-3 CASE 369D (Straight Lead) STYLE 2



Y = Year WW = Work Week NT6600 = Device Code G = Pb-Free Package

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Ch	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS			-	-		
Drain-to-Source Breakdown Voltage ( $V_{GS} = 0 \text{ Vdc}, I_D = 250  \mu\text{Adc}$ )	V <sub>(BR)DSS</sub>	100	-	_	Vdc	
Zero Gate Voltage Drain Current $(V_{GS} = 0 \text{ Vdc}, V_{DS} = 100 \text{ Vdc}, (V_{GS} = 0 \text{ Vdc}, V_{DS} = 100 \text{ Vdc}, V_{DS} = 100$	I <sub>DSS</sub>	- -	_ _	1.0 10	μAdc	
Gate-Body Leakage Current (V <sub>GS</sub>	= ±20 Vdc, V <sub>DS</sub> = 0)	I <sub>GSS</sub>	_	_	±100	nAdc
ON CHARACTERISTICS						
Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu\text{Adc})$ Temperature Coefficient (Negat	ive)	V <sub>GS(th)</sub>	1.0	1.5 -4.4	2.0	Vdc mV/°C
Static Drain-to-Source On-State F	Resistance (V <sub>GS</sub> = 5.0 Vdc, I <sub>D</sub> = 6.0 Adc)	R <sub>DS(on)</sub>	_	118	146	mΩ
Drain-to-Source On-Voltage (V <sub>GS</sub>	= 5.0 Vdc, I <sub>D</sub> = 12 Adc)	V <sub>DS(on)</sub>	_	1.5	2.2	Vdc
Forward Transconductance (V <sub>DS</sub> =	10 Vdc, I <sub>D</sub> = 6.0 Adc)	9 <sub>FS</sub>	_	10	_	mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C <sub>iss</sub>	_	463	700	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	-	116	225	
Reverse Transfer Capacitance	,	C <sub>rss</sub>	-	36	75	
SWITCHING CHARACTERISTICS	(Notes 4 & 5)					
Turn-On Delay Time		t <sub>d(on)</sub>	_	10.5	20	ns
Rise Time	(V <sub>DD</sub> = 80 Vdc, I <sub>D</sub> = 6.0 Adc,	t <sub>r</sub>	_	75	140	
Turn-Off Delay Time	$V_{GS} = 5.0 \text{ Vdc}, R_G = 9.1 \Omega$	t <sub>d(off)</sub>	_	26	40	
Fall Time	]	t <sub>f</sub>	_	50	90	
Total Gate Charge		Q <sub>tot</sub>	_	11.3	20	nC
Gate-to-Source Charge	$(V_{DS} = 80 \text{ Vdc}, I_D = 6.0 \text{ Adc}, V_{GS} = 5.0 \text{ Vdc})$	Q <sub>gs</sub>	_	1.9	_	
Gate-to-Drain Charge	56 11 11,	Q <sub>gd</sub>	_	7.4	_	
BODY-DRAIN DIODE RATINGS (N	lote 4)					
Diode Forward On-Voltage	$(I_S = 12 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 12 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V <sub>SD</sub>		0.90 0.80	1.4 -	Vdc
Reverse Recovery Time		t <sub>rr</sub>	-	80	-	ns
	$(I_S = 12 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s})$	ta	-	50	-	
	1 3 11 12 13 14 1	t <sub>b</sub>	-	30	-	
Reverse Recovery Stored Charge	$Q_{RR}$	_	0.240	_	μC	

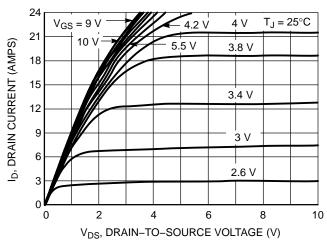
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>	
NTD6600N	DPAK		
NTD6600N-1	DPAK-3	75 Units/Rail	
NTD6600N-1G	DPAK-3 (Pb-Free)	75 Offits/Kall	
NTD6600NT4	DPAK		
NTD6600NT4G	DPAK (Pb-Free)	2500 Tape & Reel	

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Indicates Pulse Test: P.W. = 300 μs max, Duty Cycle = 2%.
 Switching characteristics are independent of operating junction temperature.

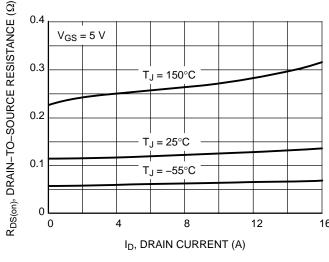
#### TYPICAL CHARACTERISTICS



25  $V_{DS} \ge 10 \text{ V}$ <sub>ID</sub>, DRAIN CURRENT (AMPS) 20 15 10  $T_J = 150^{\circ}C$ -55°C 5  $T_J = 25^{\circ}C$ 0 6 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



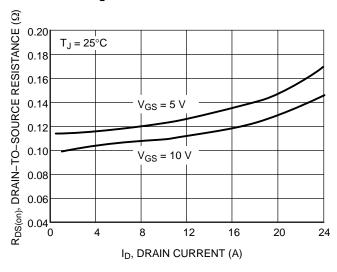
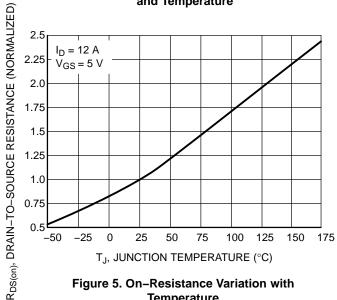


Figure 3. On-Resistance versus Drain Current and Temperature

Figure 4. On-Resistance versus Drain Current and Temperature



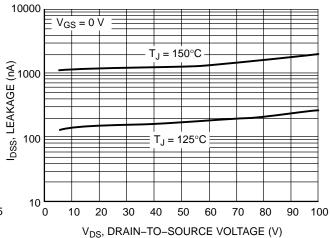


Figure 5. On-Resistance Variation with **Temperature** 

Figure 6. Drain-To-Source Leakage **Current versus Voltage** 

#### **TYPICAL CHARACTERISTICS**

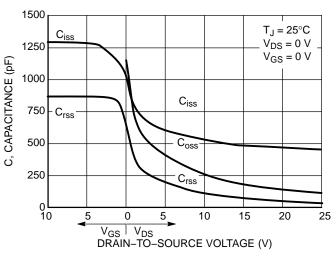


Figure 7. Capacitance Variation

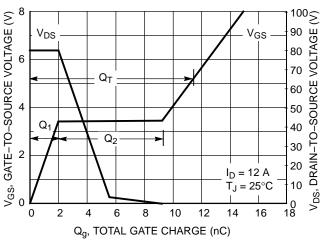


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

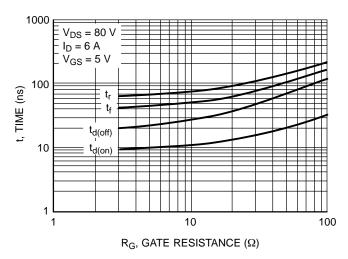


Figure 9. Resistive Switching Time Variation versus Gate Resistance

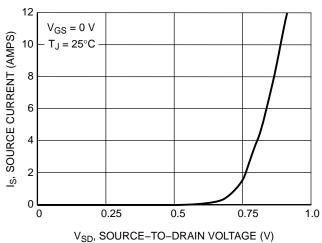


Figure 10. Diode Forward Voltage versus

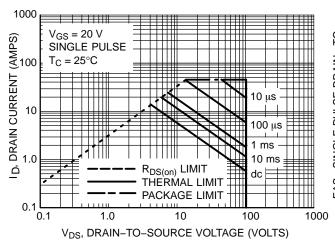


Figure 11. Maximum Rated Forward Biased Safe Operating Area

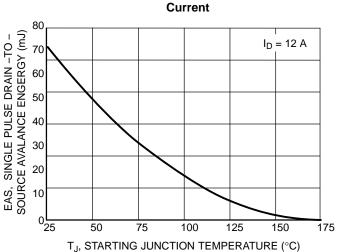
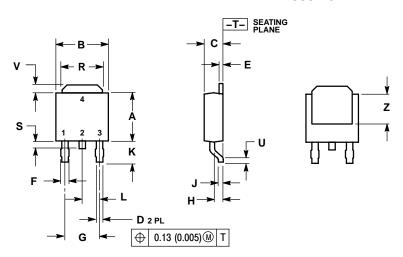


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

## **PACKAGE DIMENSIONS**

#### **DPAK** CASE 369C-01 **ISSUE O**

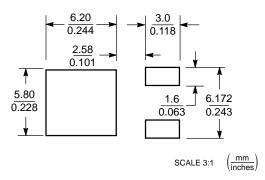


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.180	BSC	4.58 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.102	0.114	2.60	2.89	
L	0.090	0.090 BSC		BSC	
R	0.180	0.215	4.57	5.45	
S	0.025	0.040	0.63	1.01	
U	0.020		0.51		
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

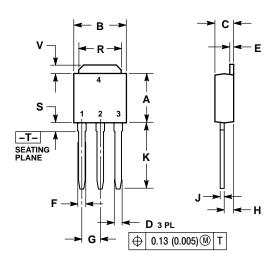
#### **SOLDERING FOOTPRINT\***

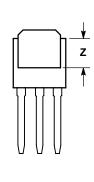


<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

DPAK-3 CASE 369D-01 ISSUE B





#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090 BSC		2.29	9 BSC	
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2: PIN 1. GATE

- 2. DRAIN
- 3. SOURCE
- DRAIN

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